

<b>Notice of References Cited</b>	Application/Control No. 10/680,930	Applicant(s)/Patent Under Reexamination CHATTERJEE ET AL.	
	Examiner Kevin M. Nguyen	Art Unit 2629	Page 1 of 1

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*	C	US-7,010,551	03-2006	Terayama et al.	707/200
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	M	US-			

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